

Notice of References Cited	Application/Control No. 10/579,454		Applicant(s)/Patent Under Reexamination DAVIS ET AL.	
	Examiner SETH WEIS		Art Unit 3695	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0225592	11-2004	Churquina, Eduardo Enrique	705/037
*	B	US-2002/0013711	01-2002	Ahuja et al.	705/1
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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